


<b>Search Notes</b> 	<b>Application/Control No.</b> 10575858	<b>Applicant(s)/Patent Under Reexamination</b> LEE, SANG RYUL
	<b>Examiner</b> Quang T Van	<b>Art Unit</b> 3742

SEARCHED			
Class	Subclass	Date	Examiner
219	739,722,715,739,702,723,724,716	7/28/2010	QV
126	197	7/28/2010	QV
200	50.12,50.13	7/28/2010	QV

SEARCH NOTES		
Search Notes	Date	Examiner
East search and inventor check	7/28/2010	QV

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
219	722,739,715	1/14/2011	QV
126	197	1/14/2011	QV

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